

Notice of References Cited	Application/Control No. 09/930,208	Applicant(s)/Patent Under Reexamination ITOU ET AL.	
	Examiner A. Sefer	Art Unit 2826	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0063826	05-2002	OKAMOTO et al.	349/117
	B	US-6,327,010	12-2001	Scheuble et al.	349/118
	C	US-2003/0058393	03-2003	Terashita et al.	349/117
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 4-116515	04-1992	Japan	Sonehara	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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